SCBS817B-JULY 2006-REVISED SEPTEMBER 2006

FEATURES

- Controlled Baseline
 - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree (1)
- Open-Collector Version of 'BCT244
- Open-Collector Outputs Drive Bus Lines or Buffer Memory Address Registers
- ESD Protection Exceeds 2000 V Per MIL-STD-883C Method 3015
- Available In Plastic Small-Outline (DW) Package
- (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

| DW PACKAGE | | | | | | | | |
|---------------|----|---|----|-------------------|--|--|--|--|
| (TOP VIEW) | | | | | | | | |
| | | | | L | | | | |
| 1 <u>0E</u> [| 1 | _ | 20 | J V _{cc} | | | | |
| 1A1 [| 2 | | 19 | 2 <u>0E</u> | | | | |
| 2Y4 [| 3 | | 18 |] 1Y1 | | | | |
| 1A2 [| 4 | | 17 | 2A4 | | | | |
| 2Y3 [| 5 | | 16 |] 1Y2 | | | | |
| 1A3 [| 6 | | 15 | 2A3 | | | | |
| 2Y2 [| 7 | | 14 | 1Y3 | | | | |
| 1A4 [| 8 | | 13 | 2A2 | | | | |
| 2Y1 [| 9 | | 12 |] 1Y4 | | | | |
| GND [| 10 | | 11 | 2A1 | | | | |

DIA DAGICAGE

DESCRIPTION/ORDERING INFORMATION

The SN74BCT760 octal buffer and line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The SN74BCT760 is organized as two 4-bit buffers/line drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

The device is characterized for operation over the full military temperature range of -55°C to 125°C.

ORDERING INFORMATION

| T _A | PACK | AGE ⁽¹⁾ | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|----------------|-----------|--------------------|-----------------------|------------------|
| −55°C to 125°C | SOIC - DW | Tape and reel | SN74BCT760MDWREP | BCT760MEP |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

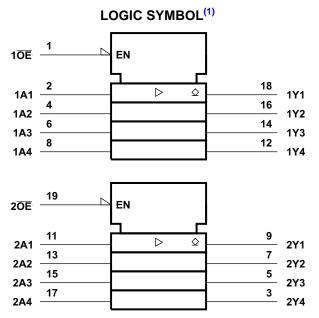
FUNCTION TABLE (each buffer)

| INP | OUTPUT | |
|-----|--------|---|
| ŌĒ | Α | Y |
| L | Н | Н |
| L | L | L |
| Н | Χ | Н |



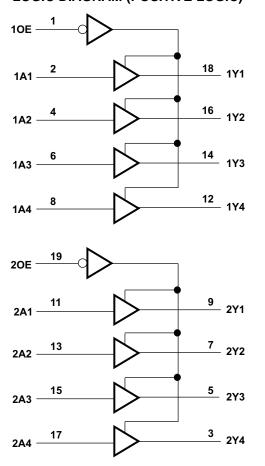
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(1) This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

LOGIC DIAGRAM (POSITIVE LOGIC)





SN74BCT760-EP OCTAL BUFFER/DRIVER WITH OPEN-COLLECTOR OUTPUTS

SCBS817B-JULY 2006-REVISED SEPTEMBER 2006

Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|------------------|--|------|----------|------|
| V_{CC} | Supply voltage range | -0.5 | 7 | V |
| VI | Input voltage range (2) | -0.5 | 7 | V |
| I _I | Input current range | -30 | 5 | mA |
| Vo | Voltage range applied to any output in the disabled or power-off state | -0.5 | 5.5 | V |
| Vo | Voltage range applied to any output in the high state | -0.5 | V_{CC} | V |
| | Current into any output in the low state | | 96 | mA |
| | Operating free-air temperature range ⁽³⁾ | -55 | 125 | °C |
| T _{stg} | Storage temperature range | -65 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The negative input voltage rating may be exceeded if the input clamp current rating is observed.

Recommended Operating Conditions

| | | MIN | NOM | MAX | UNIT |
|-----------------|--------------------------------|-----|-----|-----|------|
| V_{CC} | Supply voltage | 4.5 | 5 | 5.5 | V |
| V_{IH} | High-level input voltage | 2 | | | V |
| V_{IL} | Low-level input voltage | | | 0.8 | V |
| V_{OH} | High-level output voltage | | | 5.5 | V |
| I _{IK} | Input clamp current | | | -18 | mA |
| I _{OL} | Low-level output current | | | 48 | mA |
| T _A | Operating free-air temperature | -55 | | 125 | °C |

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDIT | MIN | TYP(1) | MAX | UNIT | |
|-----------------|---------------------------|---|------------------------|--------|------|------|----|
| V_{IK} | $V_{CC} = 4.5 V,$ | $I_I = -18 \text{ mA}$ | | | | -1.2 | V |
| V _{OL} | $V_{CC} = 4.5 \text{ V},$ | $I_{OL} = 48 \text{ mA}$ | | | 0.38 | 0.55 | V |
| I _I | $V_{CC} = 5.5 V,$ | $V_I = 7 V$ | | | | 0.1 | mA |
| I _{IH} | $V_{CC} = 5.5 V,$ | $V_1 = 2.7 \ V$ | V _I = 2.7 V | | | | μΑ |
| I _{IL} | $V_{CC} = 5.5 V,$ | $V_{I} = 0.5 V$ | V _I = 0.5 V | | | | mA |
| I _{OH} | $V_{CC} = 4.5 \text{ V},$ | $V_{OH} = 5.5 \text{ V}$ | | | | 0.1 | mA |
| | | | Outputs high | | 21 | 33 | |
| I _{CC} | $V_{CC} = 5.5 V,$ | Outputs open | Outputs low | | 48 | 76 | mA |
| | | | OE disabled | | 6 | 10 | |
| C _i | V _{CC} = 5 V, | V _I = 2.5 V or 0.5 V | | | 6 | | pF |
| Co | $V_{CC} = 5 V$, | $V_I = 2.5 \text{ V or } 0.5 \text{ V}$ | | | 10 | | pF |

(1) All typical values are at V_{CC} = 5 V, T_A = 25°C.

⁽³⁾ Long-term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life. See http://www.ti.com/ep_quality for additional information on enhanced plastic packaging.

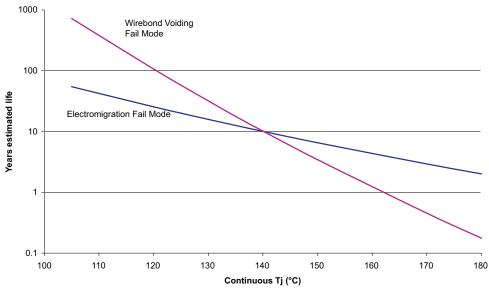


Switching Characteristics

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | R_L | CC = 5 V, = 50 pF, = 500 Ω, A = 25°C | | $V_{CC} = 4.5 \text{ V t}$ $C_L = 50$ $R_L = 500$ $T_A = \text{MIN to}$ |) Ω, | UNIT |
|------------------|-----------------|----------------|-------|---|------|---|------|------|
| | | | MIN | TYP | MAX | MIN | MAX | |
| t _{PLH} | Δην. Δ | V | 6.3 | 8 | 9.5 | 6.3 | 11.1 | 20 |
| t _{PHL} | Any A | T | 2.1 | 4.3 | 6.5 | 2.1 | 7.7 | ns |
| t _{PLH} | ŌĒ | V | 8.6 | 13 | 15.2 | 8.6 | 18.7 | 2 |
| t _{PHL} | OE . | ř | 3.2 | 6.2 | 8.9 | 3.2 | 10.4 | ns |

(1) For conditions shown as MIN or MAX, use the appropriate values specified under recommended operating conditions.

SN74BCT760MDWREP Operating Life Derating Chart

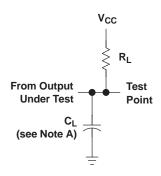


- A. See datasheet for absolute maximum ratings and minimum recommended operating conditions.
- B. Silicon operating life design goal is 10 years at 10°C junction temperature (does not include package interconnect life).
- C. Enhanced plastic product disclaimer applies.

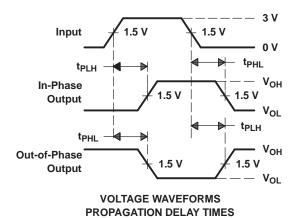




PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT FOR OPEN-COLLECTOR OUTPUTS



- A. C_L includes probe and jig capacitance.
- B. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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PACKAGING INFORMATION

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins F | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|--------|----------------|---------------------------|------------------|------------------------------|
| SN74BCT760MDWREP | ACTIVE | SOIC | DW | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| V62/06672-01XE | ACTIVE | SOIC | DW | 20 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74BCT760-EP:

Catalog: SN74BCT760Military: SN54BCT760

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

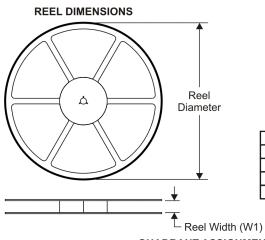
• Military - QML certified for Military and Defense Applications

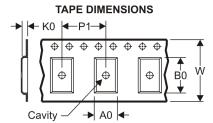




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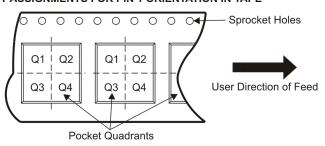
TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

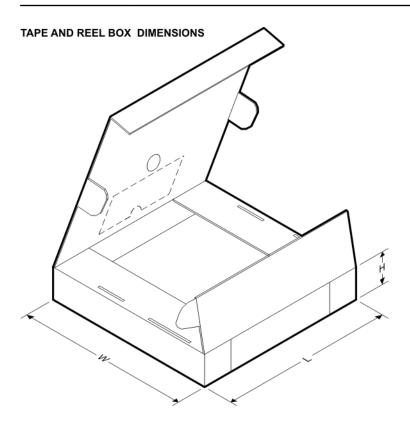


*All dimensions are nominal

| Device | | Package Drawing | _ | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|------------------|------|--------------------|----|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| SN74BCT760MDWREP | SOIC | DW | 20 | 2000 | 330.0 | 24.4 | 10.8 | 13.0 | 2.7 | 12.0 | 24.0 | Q1 |

PACKAGE MATERIALS INFORMATION



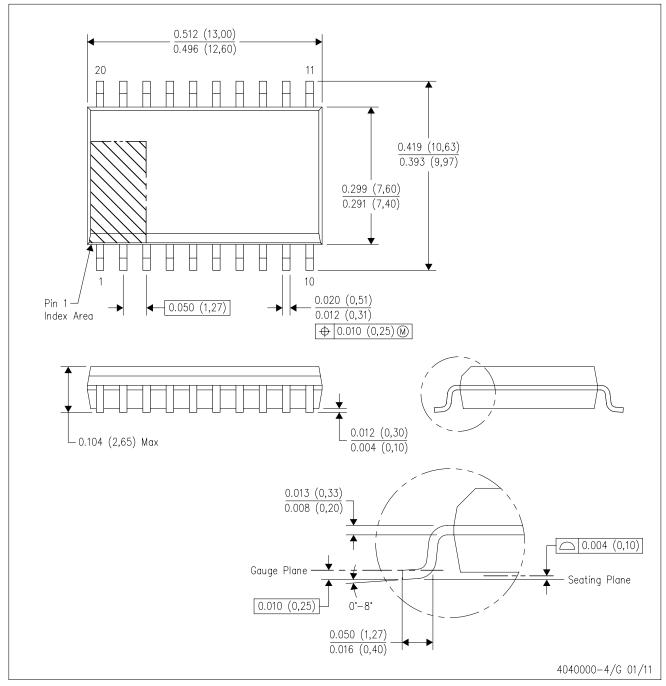


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74BCT760MDWREP | SOIC | DW | 20 | 2000 | 346.0 | 346.0 | 41.0 |

DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE

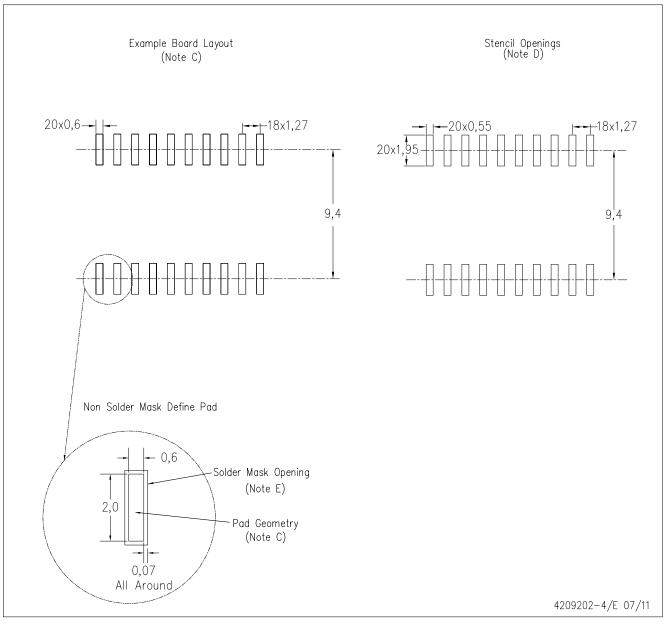


NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AC.

DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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